

SIGC25T60SNC

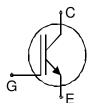
IGBT Chip in NPT-technology

FEATURES:

- 600V NPT technology
- 100μm chip
- short circuit prove
- positive temperature coefficient
- easy paralleling

This chip is used for:

- SGP30N60
- Applications:
- drives



Chip Type	V _{CE}	I _{Cn}	Die Size	Package	Ordering Code
SIGC25T60SNC	600V	30A	4.5 x 5.71 mm ²	sawn on foil	Q67041-A4667- A001
SIGC25T60SNC	600V	30A	4.5 x 5.71 mm ²	unsawn	Q67041-A4667- A002

MECHANICAL PARAMETER:

Raster size	4.5 x 5.71	mm ²			
Area total / active	25.7 / 21.4				
Emitter pad size	2x(2.18x1.58)				
Gate pad size	0.68 x 1.08				
Thickness	100	μm			
Wafer size	150	mm			
Flat position	90	deg			
Max.possible chips per wafer	566				
Passivation frontside	Photoimide				
Emitter metallization	3200 nm Al Si 1%				
Collector metallization	1400 nm Ni Ag –system suitable for epoxy and soft solder die bonding				
Die bond	electrically conductive glue or solder				
Wire bond	Al, ≤500μm				
Reject Ink Dot Size	Ø 0.65mm ; max 1.2mm	Ø 0.65mm ; max 1.2mm			
Recommended Storage Environment	store in original container, in dry nitrogen, < 6 month at an ambient temperature of 23°C				



MAXIMUM RATINGS:

Parameter	Symbol	Value	Unit
Collector-emitter voltage, Tj=25 °C	V _{CE}	600	V
DC collector current, limited by T _{jmax}	I _C	1)	А
Pulsed collector current, t_p limited by T_{jmax}	I _{cpuls}	90	А
Gate emitter voltage	V _{GE}	±20	V
Operating junction and storage temperature	T _j , T _{stg}	-55 +150	°C

¹⁾ depending on thermal properties of assembly

STATIC CHARACTERISTICS (tested on chip), $T_j=25$ °C, unless otherwise specified:

Parameter	Symbol	Conditions	Value			Unit
			min.	typ.	max.	
Collector-emitter breakdown voltage	V _{(BR)CES}	V_{GE} =0V, I _C =500 μ A	600			
Collector-emitter saturation voltage	V _{CE(sat)}	V_{GE} =15V, I _C =30A	1.6	2	2.5	V
Gate-emitter threshold voltage	$V_{\rm GE(th)}$	$I_C=700\mu A, V_{GE}=V_{CE}$	3	4	5	
Zero gate voltage collector current	I _{CES}	V_{CE} =600V, V_{GE} =0V			2.2	μA
Gate-emitter leakage current	I _{GES}	V_{CE} =0V, V_{GE} =20V			120	nA

DYNAMIC CHARACTERISTICS (tested at component):

Parameter	Symbol	Conditions	Value			Unit
Falameter			min.	typ.	max.	Unit
Input capacitance	Ciss	V _{CE} =25V	-	1600	1920	pF
Output capacitance	Coss	$V_{\rm GE}=0$ V	-	150	180	
Reverse transfer capacitance	Crss	f=1MHz	-	92	110	

SWITCHING CHARACTERISTICS (tested at component), Inductive Load:

Parameter	Symbol	Conditions ²⁾	Value			Unit
			min.	typ.	max.	Onit
Turn-on delay time	t _{d(on)}	$T_{\rm j}=150^{\circ}\rm C$ $V_{\rm CC}=400\rm V$	-	44	53	ns
Rise time	t _r	/ _C =30A	-	34	40	
Turn-off delay time	$t_{d(off)}$	$V_{\rm GE}$ =+15/0V $R_{\rm G}$ =11 Ω	-	324	389	
Fall time	t _f	,	-	67	80	

²⁾ switching conditions different to 600V Standard IGBT 2, under comparable switching conditions 40% faster turnoff than Standard IGBT 2. Values also influenced by parasitic L- and C- in measurement and package.



CHIP



722

Flat

DRAWING: Die-Size 4500 um x 5710 um 45ØØ 171Ø 1Ø8Ø Ø 1580 5710 680 3715 Ø 2515 580ģ ġ 窗 415 61Ø 218Ø

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mm

metal1

no imide



FURTHER ELECTRICAL CHARACTERISTICS:

This chip data sheet refers to the device data sheet

SGP30N60

Package :TO220

Description:

AQL 0,65 for visual inspection according to failure catalog

Electrostatic Discharge Sensitive Device according to MIL-STD 883

Test-Normen Villach/Prüffeld

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